UM11402

FRDM33771CSPEVB evaluation board

Rev. 1 — 29 June 2020

User manual



Important Notice

NXP provides the enclosed product(s) under the following conditions:

This evaluation kit is intended for use of ENGINEERING DEVELOPMENT OR EVALUATION PURPOSES ONLY. It is provided as a sample IC pre-soldered to a printed circuit board to make it easier to access inputs, outputs, and supply terminals. This evaluation board may be used with any development system or other source of I/O signals by simply connecting it to the host MCU or computer board via off-the-shelf cables. This evaluation board is not a Reference Design and is not intended to represent a final design recommendation for any particular application. Final device in an application will be heavily dependent on proper printed circuit board layout and heat sinking design as well as attention to supply filtering, transient suppression, and I/O signal quality.

The goods provided may not be complete in terms of required design, marketing, and or manufacturing related protective considerations, including product safety measures typically found in the end product incorporating the goods. Due to the open construction of the product, it is the user's responsibility to take any and all appropriate precautions with regard to electrostatic discharge. In order to minimize risks associated with the customers applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards. For any safety concerns, contact NXP sales and technical support services.

Should this evaluation kit not meet the specifications indicated in the kit, it may be returned within 30 days from the date of delivery and will be replaced by a new kit.

NXP reserves the right to make changes without further notice to any products herein. NXP makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does NXP assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. Typical parameters can and do vary in different applications and actual performance may vary over time. All operating parameters, including Typical, must be validated for each customer application by customer's technical experts.

NXP does not convey any license under its patent rights nor the rights of others. NXP products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the NXP product could create a situation where personal injury or death may occur. Should the Buyer purchase or use NXP products for any such unintended or unauthorized application, the Buyer shall indemnify and hold NXP and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and

reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges NXP was negligent regarding the design or manufacture of the part.



FRDM33771CSPEVB evaluation board

1 Getting started

NXP analog product development boards provide a platform for evaluating a broad range of NXP analog, mixed-signal and power solution products. NXP analog product development boards incorporate monolithic integrated circuits and system-in-package devices that use proven high-volume technology. NXP products offer a long battery life, a small form factor, reduced component counts, low cost, and improved performance in powering state-of-the-art systems.

The tool summary page for the FRDM33771CSPEVB evaluation board is at http://www.nxp.com/FRDM33771CSPEVB. The tool summary page provides information related to using the evaluation board. The page contains the following sections:

- Overview A brief summary of the evaluation board and its capabilities
- Supported Devices A list of devices that the evaluation board supports
- Specifications An overview of the technical and functional specifications for the board
- Documents and Software/Design Resources All of the information and resources required by users who have already purchased the FRDM33771CSPEVB. This section includes:
 - Design Tools & Flles Click on the Download button to download the board Bill of Materials and the Gerber files for the PCB assemblies.
 - Printed Circuit Boards and Schematics Click on the Download to download a .pdf version of the FRDM33771CSPEVB board schematics.

The Get Started link in the upper left of the menu bar provides information applicable to using the FRDM33771CSPEVB.

1.1 Kit contents/packing list

The kit contents include:

- · Assembled and tested evaluation board/module in anti-static bag
- 20 cm 26-pin cell terminal cable
- · Quick-start guide

1.2 Required equipment

To use this evaluation board, you need:

A 7- to 14-cell battery pack or a battery pack emulator, such as BATT-14CEMULATOR

2 Getting to know the hardware

2.1 Board overview

The FRDM33771CSPEVB serves as a hardware evaluation tool in support of NXP's MC33771C device. The MC33771C is a battery cell controller that monitors up to 14 lithium-ion battery cells. It is designed for use in both automotive and industrial applications. The device performs ADC conversions on differential cell voltages and currents. It is also capable of battery charge coulomb counting and battery temperature measurements. The FRDM33771CSPEVB is an ideal platform for rapid prototyping of MC33771C-based applications that involve current, voltage, and temperature sensing.

FRDM33771CSPEVB evaluation board

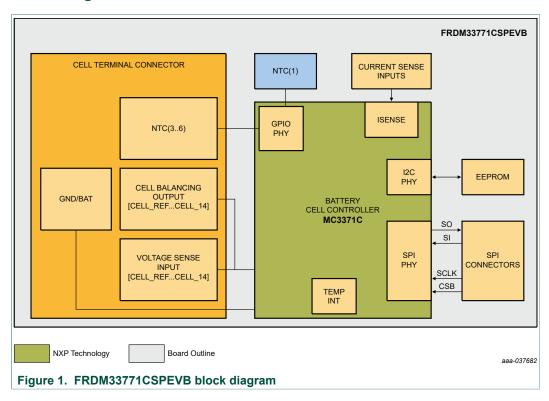
The FRDM33771CSPEVB supports a standard SPI interface. The information is digitally transmitted to a microcontroller for processing.

2.2 Board features

The FRDM33771CSPEVB's main features are:

- Standard SPI communication
- · LED indicator for operation mode
- · Cell-balancing resistors
- · Cell sense input with RC filter
- GPIO: digital I/O, wake-up inputs, convert trigger inputs, ratiometric analog inputs, analog inputs with absolute measurements
- EEPROM (connected to the IC with I²C interface) to store user-defined calibration parameters
- · Fault detection pin report
- · Current Measurement Input via external shunt

2.3 Block diagram



2.4 Device features

The MC33771C is a battery cell controller IC designed to monitor battery characteristics, such as voltage, current and temperature. The MC33771C contains all the circuit blocks necessary to perform synchronous battery cell voltage/current measurement, coulomb counting, cell temperature measurement and integrated cell balancing. The device supports the following functions:

FRDM33771CSPEVB evaluation board

Table 1. MC33771C device features

Device	Description	Features
MC33771C	Battery cell controller	 9.6 V ≤ V_{PWR} ≤ 61.6 V operation, 75 V transient 7 to 14 cells management Isolated 2.0 Mbps differential communication or 4.0 Mbps SPI Addressable on initialization Bidirectional transceiver to support up to 63 nodes in daisy chain 0.8 mV maximum total voltage measurement error Synchronized cell voltage/current measurement with coulomb count Averaging of cell voltage measurements Total stack voltage measurement Seven GPIO/temperature sensor inputs 5.0 V at 5.0 mA reference supply output Automatic over/undervoltage and temperature detection routable to fault pin Integrated sleep mode over/undervoltage and temperature monitoring Onboard 300 mA passive cell balancing with diagnostics Hot plug capable Detection of internal and external faults, as open lines, shorts, and leakages Designed to support ISO 26262, up to ASIL D safety system Qualified in compliance with AECQ-100

2.5 Board description

The FRDM33771CSPEVB allows the user to exercise all the functions of the MC33771C battery controller cell.

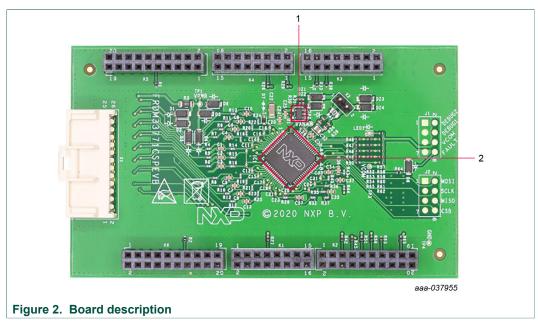


Table 2. Board components

Num ber	Label	Name	Description
1	U1	24LC01BT-I/OT	IC memory EEPROM

FRDM33771CSPEVB evaluation board

Num ber	Label	Name	Description
2	IC1	MC33771C	Battery-cell controller IC

2.6 VCOM LED

The VCOM LED is located on the board as shown in Figure 3.

The VCOM LED indicates when the device is in normal mode. Upon reset, the MC33771C enters into normal mode (VCOM turns on). If there is no activity on the bus after a timeout period of 60 seconds, the device enters low-power idle mode (VCOM turns off). Once the device is initialized, if no communication occurs on the TPL bus after one second, the device resets and the LED turns off (VCOM off).

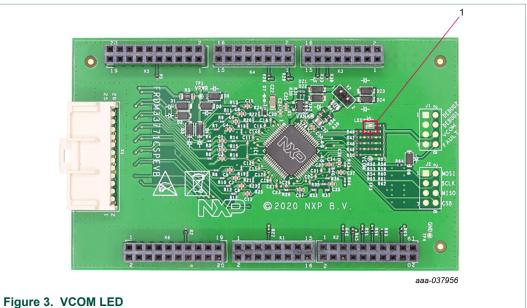


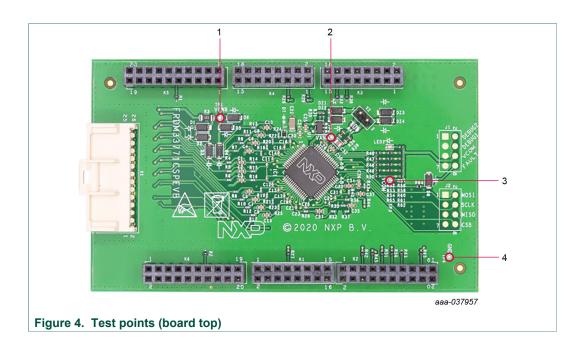
Table 3. Board Description

Num ber	Label	Name	Description
1	LED1	VCOM LED	Indicates whether the device is in normal mode or in low power mode

2.7 Test-point definitions

The following test points provide access to various signals to and from the board. Figure 4 and Figure 5 show the location of the test points on the board.

FRDM33771CSPEVB evaluation board



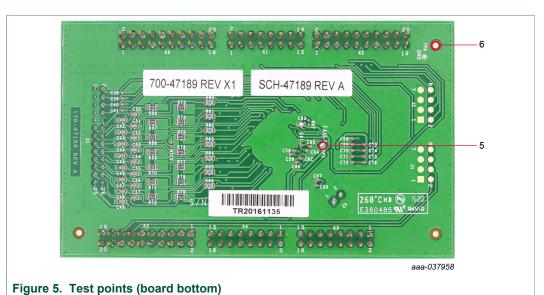


Table 4. Test points

Num ber	Label	Signal name	Description
1	TP1	VPWR	Power input to the device
2	TP2	VANA	Precision ADC analog supply output
3	TP3	VCOM	Communication regulator output
4	TP4	GND	Ground reference of the device
5	TP5	FAULT	Device FAULT pin for user defined internal and external faults
6	TP6	GND	Ground reference of the device

FRDM33771CSPEVB evaluation board

2.8 Connectors

<u>Figure 6</u> shows the location of connectors on the board. The accompanying tables list the pinouts for each connector.

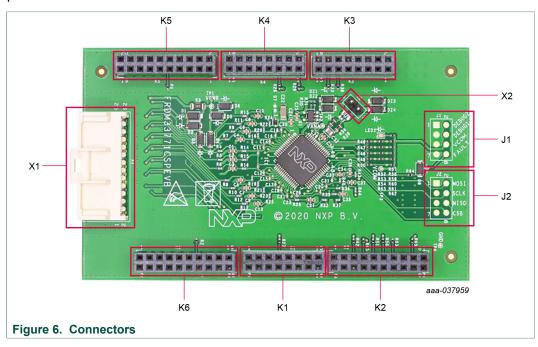


Table 5. SPI Connector (K1)

Pin Number	Connection	Description
7	FAULT	Connects via FAULT_MCU to the device FAULT pin
Other	_	No connection

Table 6. SPI Connector (K2)

Pin Number	Connection	Description
5	CSB, J2-8	Connects via CSB to: • the device CSB pin • debug connector J2 pin 8
7	SI/RDTX_IN+, J2-2	Connects via MOSI to: • the device SI/RDTX_IN+ pin • debug connector J2 pin 2
9	SO, J2-6	Connects via MISO to: • the device SO pin • debug connector J2 pin 6
11	SCLK/RDTX_IN-, J2-4	Connects via SCLK to: the device SCLK/RDTX_IN- pin debug connector J2 pin 4
13	GND	Connects to the device ground reference

FRDM33771CSPEVB evaluation board

Pin Number	Connection	Description
17	GPIO0	Connects via GPIO_WAKEUP to the device GPIO0 pin
Other	_	No connection

Table 7. SPI Connector (K3)

Table 11 C. 1 Commode (110)			
Pin Number	Connection	Description	
11	GND	Connects to the device ground reference	
13	GND	Connects to the device ground reference	
Other	_	No connection	

Table 8. SPI Connector (K4)

Pin Number	Connection	Description
1	RESET	Connects via RESET to the device RESET pin
5	GPIO2	Connects via GPIO2_SOC to the device GPIO2 pin
Other	_	No connection

Table 9. SPI Connector (K5)

Pin Number	Connection	Description
12	GND	Connects to the device ground reference
13	DEBUG1	Connects via DEBUG1 to DEBUG1 (pin 4) on SPI Analyzer Interface connector J1
15	DEBUG2	Connects via DEBUG2 to DEBUG2 (pin 2) on SPI Analyzer Interface connector J1
Other	_	No connection

Table 10. SPI Connector (K6)

Pin Number	Connection	Description
12	GND	Connects to the device ground reference
Other	_	No connection

Table 11. Debug connector (J1)

Pin Number	Connection	Description
2	DEBUG2	Connects via DEBUG2 to pin 15 on connector K5

FRDM33771CSPEVB evaluation board

Pin Number	Connection	Description
4	DEBUG1	Connects via DEBUG1 to pin 13 on connector K5
6	VCOM	Connects to the device VCOM pin
8	FAULT, K1-7	Connects via FAULT_MCU to: the device FAULT pin pin 7 on connector K1
Other	GND	Connects to the device ground reference

Table 12. Debug connector (J2)

Pin Number	Connection	Description
2	SI/RDTX_IN+, K2-7	Connects via MOSI to: • the device SI/RDTX_IN+ pin • pin 7 on connector K2
4	SCLK/RDTX_IN-, K2-11	Connects via SCLK to: • the device SCLK/RDTX_IN- pin • pin 11 on connector K2
6	SO, K2-9	Connects via MISO to: • the device SO pin • pin 9 on connector K2
8	CSB, K2-5	Connects via CSB to: • the device CSB pin • in 5 on connector K2
Other	GND	Connects to thep q device ground reference

Table 13. Cell terminal connector (X1)

Pin	Connection	Description
1	GND	NTC connection (-)
2	NTC6	NTC connection (+)
3	GND	NTC connection (-)
4	NTC5	NTC connection (+)
5	GND	NTC connection (-)
6	NTC4	NTC connection (+)
7	GND	NTC connection (-)
8	NTC3	NTC connection (+)
9	GND	negative battery
10	GND	negative battery
11	CELL_1	Battery cell1P connection
12	CELL_REF	Battery cell1M connection

FRDM33771CSPEVB evaluation board

Pin	Connection	Description
13	CELL_3	Battery cell3P connection
14	CELL_2	Battery cell2P connection
15	CELL_5	Battery cell5P connection
16	CELL_4	Battery cell4P connection
17	CELL_7	Battery cell7P connection
18	CELL_6	Battery cell6P connection
19	CELL_9	Battery cell9P connection
20	CELL_8	Battery cell8P connection
21	CELL_11	Battery cell11P connection
22	CELL_10	Battery cell10P connection
23	CELL_13	Battery cell13P connection
24	CELL_12	Battery cell12P connection
25	VBAT	positive battery
26	CELL_14	Battery cell14P connection

Table 14. ISENSE filter connector (X2)

Pin number	Connection	Description
1		Connects via ISENSE to the device ISENSE- pin
2		Connects via ISENSE_+ to the device ISENSE+ pin

2.9 External EEPROM

The FRDM33771CSPEVB has an integrated gateway communication link to an external local EEPROM. The MC33771C's I²C Communication Interface manages communication with the EEPROM.

After a reset, the EEPROM is not enabled. When the EEPROM is enabled, the device can load the EEPROM calibration parameters into the MC33771C registers.

For more information on using an external EEPROM with the MC33771C device, see the MC33771C data sheet.

2.10 GPIO configuration

The MC33771C has seven GPIOs pins available for external connections. On the FRDM33771CSPEVB, those pins are allocated as follows:

- GPIO0 is connected to the S32K connector K2 for the wakeup function
- GPIO1 is connected to an onboard NTC for EVB temperature measurement
- GPIO2 is connected to the S32K connector K4 for Start Of Conversion (SOC) requests
- GPIO3 through GPIO6 are available for temperature measurement through connector X1 to an external NTC

FRDM33771CSPEVB evaluation board

2.11 Cell terminal voltage measurement

The differential measurement of each cell terminal input is designed to function in conjunction with an external anti-aliasing filter with a corner frequency.

2.12 Current sensing

The FRDM33771CSPEVB supports a current sense function with an off-board shunt resistor. The off-board shunt resistor must be connected between X2-2 (ISENSE+) and X2-1 (ISENSE-). Please refer to the MC33771C datasheet regarding the maximum voltage that can be applied on these pins. The on-board current sensing filter and protection circuits are found in the FRDM33771CSPEVB Tool Summary Page: mxp.com/ FRDM33771CSPEVB.

2.13 SPI communication interface

The MC33771C SPI interface is a standard SPI slave interface with a chip select (CSB), clock (SCLK), Slave Out (SO), and Slave In (SI). The SI/SO shifting of the data follows a first-in-first-out protocol, with both input and output words transferring the Most Significant Bit (MSB) first.

All SPI communication to the MC33771C is controlled by the microcontroller. One 48-bit register of previously requested data is retrieved through serial out for each current serial in message sent by the MCU. For message integrity and communication robustness, each SPI transmit message consists of six fields containing 48 bits.

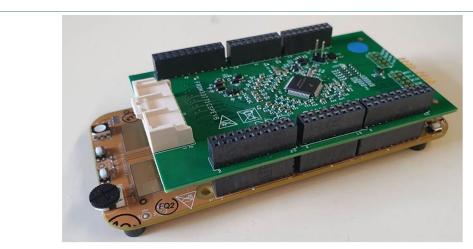
3 Configuring the hardware

The FRDM33771CSPEVB can be configured as a shield board connected to an S32K144EVB board.

3.1 Board configuration

See <u>Figure 7</u>. When both boards are connected together, the SPI connector is directly connected with the MCU SPI pins. In this configuration, power is supplied to the S32K144EVB through a USB cable connected between the S32K144EVB board and a PC. No external power supply is required.

FRDM33771CSPEVB evaluation board



aaa-037960

Figure 7. FRDM33771CSPEVB mounted to a S32K144EVB board

3.2 Battery emulator connection

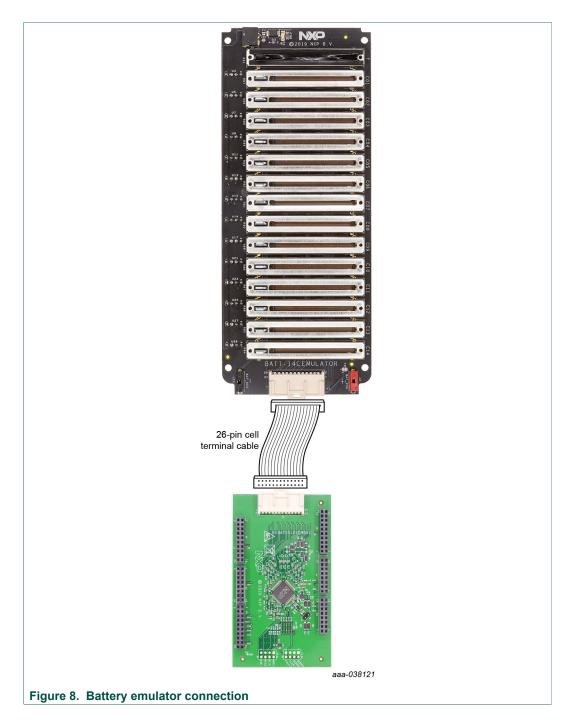
The FRDM33771CSPEVB supports the use of a battery cell emulator such as NXP's BATT-14CEMULATOR board.

The BATT-14CEMULATOR is a 14-cell battery emulator board that provides an intuitive way to change the voltage across any of the 14 cells and four voltage outputs in order to emulate four external NTC. A minimum of 7 cells and a maximum of 14 cells can be monitored.

The emulator board can be connected to the FRDM33771CSPEVB connector X1 using the provided supply cable. See Figure 8

To exercise the FRDM33771CSPEVB in combination with the BAT-14CEMULATOR, a graphical user interface is available at https://www.nxp.com/webapp/Download?colCode=KIT33771C V5 APPSP

FRDM33771CSPEVB evaluation board



4 References

- [1] FRDM3771CSPEVB tool summary page detailed information on the board, including documentation, downloads, software and tools

 nxp.com/FRDM33771CSPEVB
- [2] Product summary page product information on the MC33771C 14-Channel Li-ion Battery Cell Controller https://www.nxp.com/products/power-management/battery-management/battery-cell-controllers/14-channel-li-ion-battery-cell-controller-ic:MC33771C

UM11402

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2020. All rights reserved.

FRDM33771CSPEVB evaluation board

- [3] Tool summary page for battery emulators detailed information on the cell battery pack emulator, including documentation, downloads, software and tools

 https://www.nxp.com/design/development-boards/analog-toolbox/14-cell-battery-pack-emulator-to-supply-mc33771c-bcc-evbs:BATT-14CEMULATOR
- [4] NXP DocStore released NXP documents available to users docstore.nxp.com

5 Revision history

Table 15. Revision history

Rev	Date	Description
v.1	20200629	Initial release

FRDM33771CSPEVB evaluation board

6 Legal information

6.1 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

6.2 Disclaimers

Limited warranty and liability - Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors. In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory. Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification. Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products. NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this

Suitability for use in automotive applications — This NXP Semiconductors product has been qualified for use in automotive

applications. Unless otherwise agreed in writing, the product is not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Evaluation products — This product is provided on an "as is" and "with all faults" basis for evaluation purposes only. NXP Semiconductors, its affiliates and their suppliers expressly disclaim all warranties, whether express, implied or statutory, including but not limited to the implied warranties of non-infringement, merchantability and fitness for a particular purpose. The entire risk as to the quality, or arising out of the use or performance, of this product remains with customer. In no event shall NXP Semiconductors, its affiliates or their suppliers be liable to customer for any special, indirect. consequential, punitive or incidental damages (including without limitation damages for loss of business, business interruption, loss of use, loss of data or information, and the like) arising out the use of or inability to use the product, whether or not based on tort (including negligence), strict liability, breach of contract, breach of warranty or any other theory, even if advised of the possibility of such damages. Notwithstanding any damages that customer might incur for any reason whatsoever (including without limitation, all damages referenced above and all direct or general damages), the entire liability of NXP Semiconductors, its affiliates and their suppliers and customer's exclusive remedy for all of the foregoing shall be limited to actual damages incurred by customer based on reasonable reliance up to the greater of the amount actually paid by customer for the product or five dollars (US\$5.00). The foregoing limitations, exclusions and disclaimers shall apply to the maximum extent permitted by applicable law, even if any remedy fails of its essential purpose.

Safety of high-voltage evaluation products — The non-insulated high voltages that are present when operating this product, constitute a risk of electric shock, personal injury, death and/or ignition of fire. This product is intended for evaluation purposes only. It shall be operated in a designated test area by personnel that is qualified according to local requirements and labor laws to work with non-insulated mains voltages and high-voltage circuits. The product does not comply with IEC 60950 based national or regional safety standards. NXP Semiconductors does not accept any liability for damages incurred due to inappropriate use of this product or related to non-insulated high voltages. Any use of this product is at customer's own risk and liability. The customer shall fully indemnify and hold harmless NXP Semiconductors from any liability, damages and claims resulting from the use of the product.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — While NXP Semiconductors has implemented advanced security features, all products may be subject to unidentified vulnerabilities. Customers are responsible for the design and operation of their applications and products to reduce the effect of these vulnerabilities on customer's applications and products, and NXP Semiconductors accepts no liability for any vulnerability that is discovered. Customers should implement appropriate design and operating safeguards to minimize the risks associated with their applications and products.

6.3 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

NXP — is a trademark of NXP B.V.

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2020. All rights reserved.

FRDM33771CSPEVB evaluation board

Tables

Tab. 1.	MC33771C device features4	Tab. 9.	SPI Connector (K5)	8
Tab. 2.	Board components4	Tab. 10.	SPI Connector (K6)	8
Tab. 3.	Board Description5	Tab. 11.		8
Tab. 4.	Test points6	Tab. 12.		
Tab. 5.	SPI Connector (K1)7	Tab. 13.	Cell terminal connector (X1)	
Tab. 6.	SPI Connector (K2)7		ISENSE filter connector (X2)	
Tab. 7.	SPI Connector (K3)8	Tab. 15.	· · ·	
Tab. 8.	SPI Connector (K4)8		•	
				
Figui	'es			
Fig. 1.	FRDM33771CSPEVB block diagram3	Fig. 6.	Connectors	
Fig. 2.	Board description4	Fig. 7.	FRDM33771CSPEVB mounted to	
Fig. 3.	VCOM LED5	_	S32K144EVB board	12
Fig. 4.	Test points (board top)6	Fig. 8.	Battery emulator connection	13
Fig. 5	Test points (board bottom) 6	-	•	

FRDM33771CSPEVB evaluation board

Contents

1	Getting started	2
1.1	Kit contents/packing list	
1.2	Required equipment	
2	Getting to know the hardware	2
2.1	Board overview	
2.2	Board features	3
2.3	Block diagram	3
2.4	Device features	
2.5	Board description	4
2.6	VCOM LED	5
2.7	Test-point definitions	5
2.8	Connectors	7
2.9	External EEPROM	10
2.10	GPIO configuration	10
2.11	Cell terminal voltage measurement	11
2.12	Current sensing	11
2.13	SPI communication interface	11
3	Configuring the hardware	11
3.1	Board configuration	11
3.2	Battery emulator connection	12
4	References	13
5	Revision history	14
6	Legal information	15

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

NXP:

FRDM33771CSPEVB